

January 2016

FQP3P50

P-Channel QFET® MOSFET

-500 V, -2.7 A, 4.9 Ω

Description

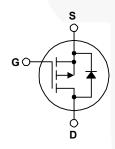
This P-Channel enhancement mode power MOSFET is $ext{-}2.7 \text{ A}, -500 \text{ V}, R_{DS(on)} = 4.9 \Omega \text{ (Max.)} @ V_{GS} = -10 \text{ V},$ produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state

• Low Gate Charge (Typ. 18 nC) resistance, and to provide superior switching performance • Low Crss (Typ 9.5 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, • 100% Avalanche Tested DC motor control, and variable switching power applications.

Features

- $I_D = -1.35 A$





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQP3P50	Unit
V_{DSS}	Drain-Source Voltage		-500	V
I _D	Drain Current - Continuous (T _C = 25°C)		-2.7	Α
	- Continuous (T _C = 100°C)		-1.71	Α
I _{DM}	Drain Current - Pulsed	Note 1)	-10.8	Α
V_{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		250	mJ
I _{AR}	Avalanche Current (Note 1)		-2.7	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		8.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-4.5	V/ns
P_{D}	Power Dissipation (T _C = 25°C)		85	W
	- Derate above 25°C		0.68	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQP3P50	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	1.47	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQP3P50	FQP3P50	TO-220	Tube	N/A	N/A	50 units

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Uni
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$				V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		0.42		V/°C
I _{DSS}	7 0	V _{DS} = -500 V, V _{GS} = 0 V			-1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = -400 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -1.35 A		3.9	4.9	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = -50 \text{ V}, I_{D} = -1.35 \text{ A}$		2.35	\	S
Dynam	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$	\	510	660	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		70	90	pF
C _{rss}	Reverse Transfer Capacitance			9.5	12	pF
Switch	ing Characteristics					
					35	
	Turn-On Delay Time	V - 250 V I - 2.7 A		12		ns
t _{d(on)}	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = -250 \text{ V}, I_D = -2.7 \text{ A},$ $R_D = 25.0$		12 56	120	
t _{d(on)} t _r	•	$V_{DD} = -250 \text{ V, } I_{D} = -2.7 \text{ A,}$ $R_{G} = 25 \Omega$			120 80	ns ns ns
t _{d(on)} t _r t _{d(off)}	Turn-On Rise Time			56		ns
t _{d(on)} t _r t _{d(off)}	Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		56 35	80	ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_G = 25 \Omega$ (Note 4)		56 35 45	80 100	ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_{gs}	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \Omega$ (Note 4) $V_{DS} = -400 \text{ V, } I_D = -2.7 \text{ A,}$	 	56 35 45 18	80 100	ns ns ns nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 \Omega$ (Note 4) $V_{DS} = -400 \text{ V}, I_{D} = -2.7 \text{ A}, V_{GS} = -10 \text{ V}$ (Note 4)	 	56 35 45 18 3.6	80 100 23 	ns ns ns
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_G = 25 \ \Omega$ (Note 4) $V_{DS} = -400 \ V, \ I_D = -2.7 \ A,$ $V_{GS} = -10 \ V$ (Note 4) $N_{CS} = -10 \ V$	 	56 35 45 18 3.6	80 100 23 	ns ns ns nC

Q_{rr} Notes:

 V_{SD}

 t_{rr}

1. Repetitive rating : pulse-width limited by maximum junction temperature.

Drain-Source Diode Forward Voltage

2. L = 62 mH, I $_{AS}$ = -2.7 A, V $_{DD}$ = -50 V, R $_{G}$ = 25 Ω , starting T $_{J}$ = 25°C. 3. I $_{SD}$ \leq -2.7 A, di/dt \leq 200 A/ μs , V $_{DD}$ \leq BV $_{DSS}$, starting T $_{J}$ = 25°C.

Reverse Recovery Time

Reverse Recovery Charge

- 4. Essentially independent of operating temperature.

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ns

μС

-5.0

270

1.5

 $V_{GS} = 0 \text{ V}, I_{S} = -2.7 \text{ A}$

 $V_{GS} = 0 \text{ V}, I_{S} = -2.7 \text{ A},$

 $dI_F / dt = 100 A/\mu s$

Typical Characteristics

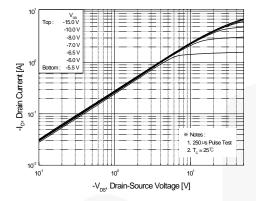


Figure 1. On-Region Characteristics

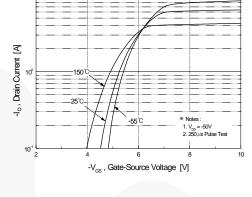


Figure 2. Transfer Characteristics

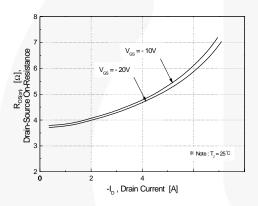


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

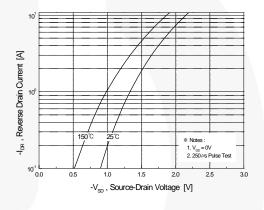


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

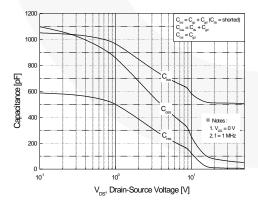


Figure 5. Capacitance Characteristics

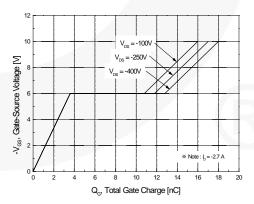


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

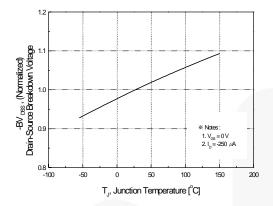


Figure 7. Breakdown Voltage Variation vs. Temperature

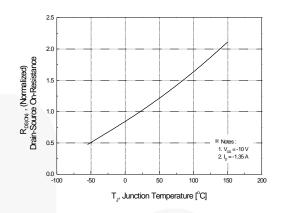


Figure 8. On-Resistance Variation vs. Temperature

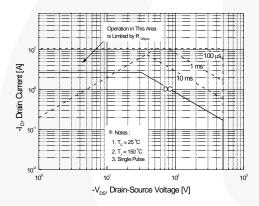


Figure 9. Maximum Safe Operating Area

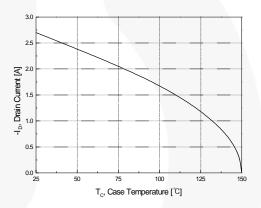


Figure 10. Maximum Drain Current vs. Case Temperature

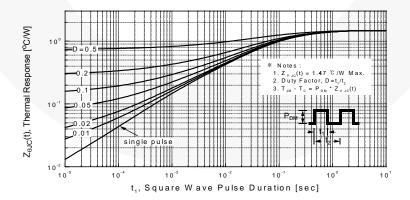


Figure 11. Transient Thermal Response Curve

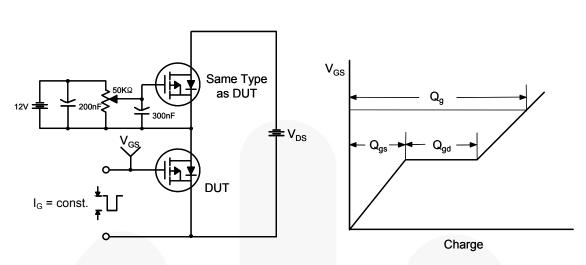


Figure 12. Gate Charge Test Circuit & Waveform

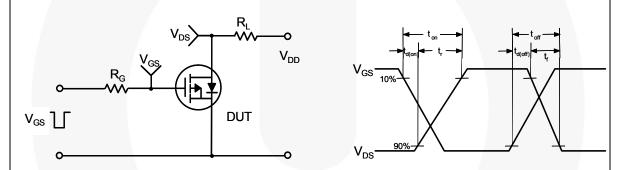


Figure 13. Resistive Switching Test Circuit & Waveforms

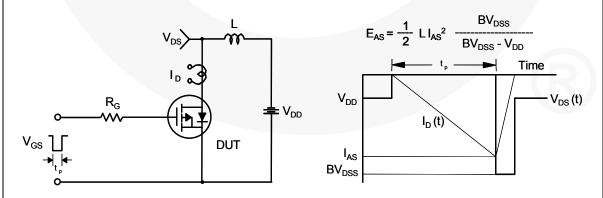
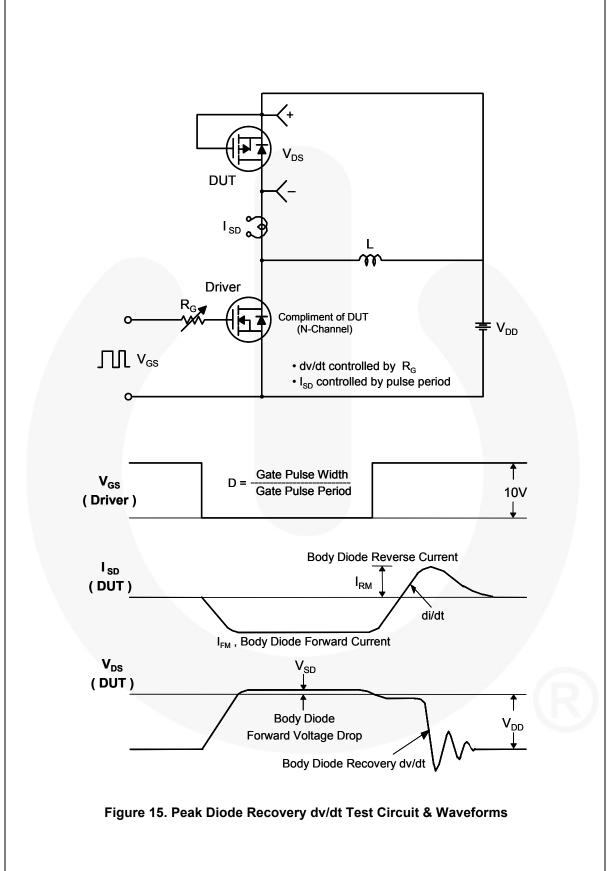


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

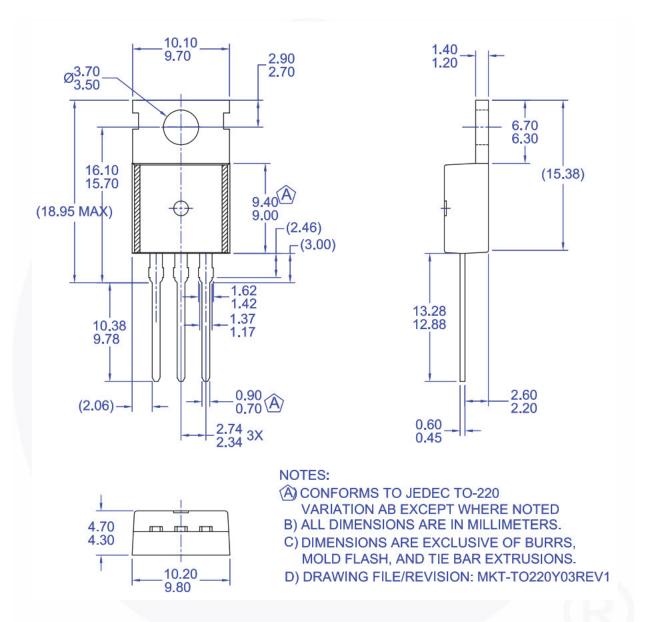


Figure 16. TO220, Molded, 3-Lead, Jedec Variation AB

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